

### SEMITOP®E2

#### 3-Level TNPC Inverter

# **Engineering Sample SK200TMLI12F4TE2**

**Target Data** 

#### **Features**

- · Low inductive design
- · Press-Fit contact technology
- Rugged mounting due to integrated mounting clamps
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DBC)
- 1200V Fast Trench4 IGBT and 650V Trench3 IGBT technology
- CAL4F technology FWD
- Integrated NTC temperature sensor
- UL recognized, file no. E 63 532

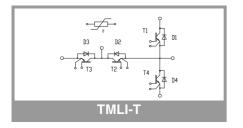
#### Remarks\*

• Recommended Tjop= -40 ... +150°C

IGBT1: outer IGBTs T1 & T4
IGBT2: inner IGBTs T2 & T3
Diode1: outer diodes D1 & D4

• Diode2: inner diodes D2 & D3

Absolute	Maximum Rati	ngs				
Symbol	Conditions		Values	Unit		
IGBT1						
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V		
Ic	T <sub>i</sub> = 175 °C	T <sub>s</sub> = 25 °C	154	Α		
	$ I_j  = 1/5$ C	T <sub>s</sub> = 70 °C	124	Α		
I <sub>Cnom</sub>			200	Α		
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>		600	Α		
$V_{GES}$			-20 20	V		
t <sub>psc</sub>	$V_{CC} = 800 \text{ V}, V_{GE} \le 15 \text{ V}, T_j = 150 \text{ °C}, V_{CES} \le 1200 \text{ V}$		10	μs		
Tj			-40 175	°C		
IGBT2						
$V_{CES}$	T <sub>j</sub> = 25 °C		650	V		
I <sub>C</sub>	T 175.00	T <sub>s</sub> = 25 °C	79	Α		
	− T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	63	Α		
I <sub>Cnom</sub>			100	Α		
I <sub>CRM</sub>	$I_{CRM} = 3 \times I_{Cnom}$		300	Α		
$V_{GES}$			-20 20	V		
t <sub>psc</sub>	$V_{CC} = 360 \text{ V}, V_{GE} \le 15 \text{ V}, T_j = 150 \text{ °C}, V_{CES} \le 650 \text{ V}$		6	μs		
Tj			-40 175	°C		
Diode1	•					
$V_{RRM}$	T <sub>j</sub> = 25 °C		1200	V		
l <sub>F</sub>	T 175 °C	T <sub>s</sub> = 25 °C	67	Α		
	− T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	53	Α		
I <sub>Fnom</sub>		<u>'</u>	75	Α		
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>		150	Α		
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 25 °C		430	Α		
Tj			-40 175	°C		
Diode2	1		l			
$V_{RRM}$	T <sub>j</sub> = 25 °C		650	V		
I <sub>F</sub>		T <sub>s</sub> = 25 °C	83	Α		
	− T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	64	Α		
I <sub>Fnom</sub>			100	Α		
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>		200	Α		
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>i</sub> = 25 °C		820	Α		
T <sub>j</sub>	, ,		-40 175	°C		
Module	1		<u> </u>	I		
I <sub>t(RMS)</sub>			t.b.d.	Α		
T <sub>stg</sub>			-40 125	°C		
V <sub>isol</sub>	AC, sinusoidal, t = 1 min		2500	V		
	1		2300			





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#### **Typical Applications**

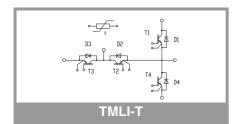
· Three-level inverter

#### Remarks\*

• Recommended Tjop= -40 ... +150°C

IGBT1: outer IGBTs T1 & T4
IGBT2: inner IGBTs T2 & T3
Diode1: outer diodes D1 & D4
Diode2: inner diodes D2 & D3

Characte	eristics					
Symbol	Conditions	min.	typ.	max.	Unit	
IGBT1			·			
V <sub>CE(sat)</sub>	I <sub>C</sub> = 200 A	T <sub>j</sub> = 25 °C		2.05	2.40	٧
	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 150 °C		2.50	2.85	٧
V <sub>CE0</sub>	chiplevel	T <sub>i</sub> = 25 °C		0.80	0.90	V
V CE0	chiplevel	$T_i = 150 ^{\circ}\text{C}$		0.70	0.80	V
ron	V <sub>GE</sub> = 15 V	T <sub>i</sub> = 25 °C		6.3	7.5	mΩ
r <sub>CE</sub>	chiplevel	T <sub>i</sub> = 150 °C		9.0	10	mΩ
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}, I_{C} = 7.6$	<u>'</u>	5.2	5.8	6.4	V
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = 1$				-	mA
C <sub>ies</sub>		f = 1 MHz		12.3		nF
Coes	$V_{CE} = 25 \text{ V}$	f = 1 MHz				nF
C <sub>res</sub>	$V_{GE} = 0 V$	f = 1 MHz		0.69		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V+ 15			1130		nC
R <sub>Gint</sub>	T <sub>i</sub> = 25 °C			3.8		Ω
t <sub>d(on)</sub>	V <sub>CE</sub> = 300 V	T <sub>i</sub> = 150 °C				ns
t <sub>r</sub>	I <sub>C</sub> = 150 A	T <sub>i</sub> = 150 °C				ns
E <sub>on</sub>	$V_{GE} = +15/-15 \text{ V}$ $R_{G \text{ on}} = 2.5 \Omega$	T <sub>i</sub> = 150 °C		7.2		mJ
t <sub>d(off)</sub>	$R_{G \text{ off}} = 2.5 \Omega$	T <sub>i</sub> = 150 °C				ns
t <sub>f</sub>		T <sub>j</sub> = 150 °C				ns
E <sub>off</sub>		T <sub>j</sub> = 150 °C		4.5		mJ
R <sub>th(j-s)</sub>	per IGBT			0.4		K/W
IGBT2			I			1
V <sub>CE(sat)</sub>	I <sub>C</sub> = 100 A	T <sub>i</sub> = 25 °C		1.45	1.85	٧
	V <sub>GE</sub> = 15 V	T <sub>i</sub> = 150 °C		1.70	2.10	V
V	chiplevel	T <sub>i</sub> = 25 °C		0.90	1.00	V
V <sub>CE0</sub>	chiplevel	$T_i = 150 ^{\circ}\text{C}$		0.90		V
r	V 15 V	T <sub>j</sub> = 25 °C		5.5	0.90 8.5	mΩ
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	$T_i = 150 ^{\circ}\text{C}$		8.8	12	mΩ
V <sub>GE(th)</sub>		,	5	5.8	6.5	V
I <sub>CES</sub>	$V_{GE} = V_{CE}, I_{C} = 1.6 \text{ mA}$ $V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_{i} = 25 \text{ °C}$		+ -	5.0	-	mA
C <sub>ies</sub>		f = 1 MHz		6.16		nF
C <sub>oes</sub>	V <sub>CE</sub> = 25 V	f = 1 MHz		0.384		nF
C <sub>res</sub>	$V_{GE} = 0 V$	f = 1 MHz		0.183		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V+ 15			800		nC
R <sub>Gint</sub>	T <sub>i</sub> = 25 °C	•		2.0		Ω
t <sub>d(on)</sub>	$V_{CE} = 300 \text{ V}$	T <sub>i</sub> = 150 °C		2.0		ns
t <sub>r</sub>	I <sub>C</sub> = 100 A	$T_i = 150  ^{\circ}\text{C}$				ns
E <sub>on</sub>	$V_{GE} = +15/-15 \text{ V}$	$T_i = 150  ^{\circ}\text{C}$		2.2		mJ
t <sub>d(off)</sub>	$R_{G \text{ on}} = 2.5 \Omega$	$T_{j} = 150 \text{ °C}$				ns
t <sub>f</sub>	$R_{G \text{ off}} = 2.5 \Omega$	T <sub>i</sub> = 150 °C				ns
박	-	1] = 130 0				110
E <sub>off</sub>		T <sub>j</sub> = 150 °C		2.6		mJ
R <sub>th(j-s)</sub>	per IGBT			1		K/W





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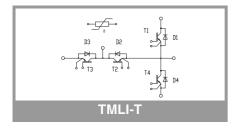
#### Remarks\*

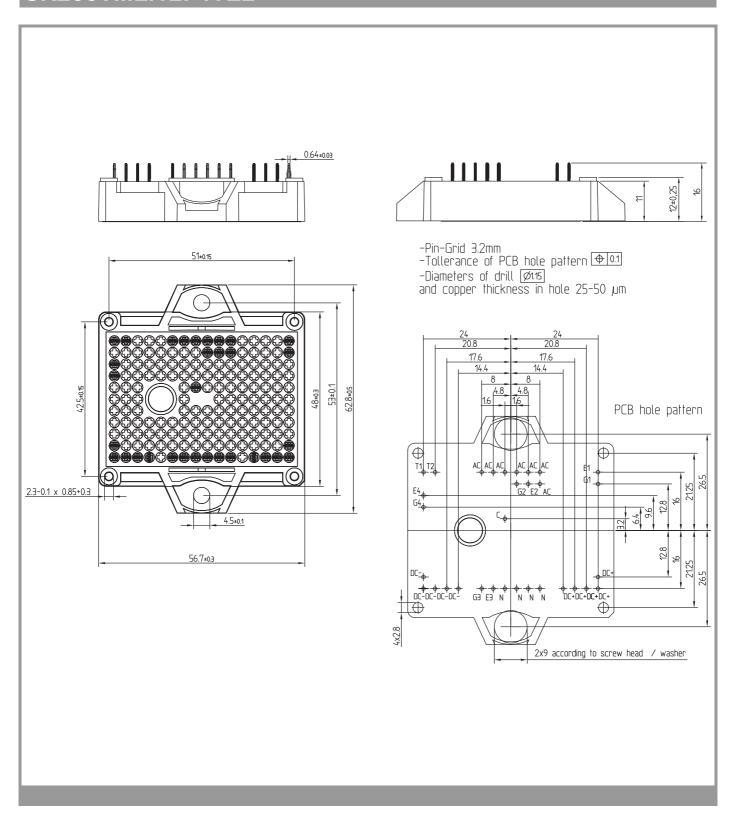
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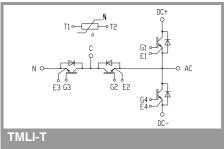
IGBT1: outer IGBTs T1 & T4
IGBT2: inner IGBTs T2 & T3
Diode1: outer diodes D1 & D4

• Diode2: inner diodes D2 & D3

Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Diode1						
$V_F = V_{EC}$	I <sub>F</sub> = 75 A	T <sub>j</sub> = 25 °C		2.17	2.49	V
	chiplevel	T <sub>j</sub> = 150 °C		2.11	2.42	V
V <sub>F0</sub>		T <sub>i</sub> = 25 °C		1.30	1.50	V
ch	chiplevel	T <sub>i</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	1	T <sub>i</sub> = 25 °C		12	13	mΩ
	chiplevel	T <sub>j</sub> = 150 °C		16	18	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 75 A	T <sub>j</sub> = 150 °C		-		Α
Q <sub>rr</sub>		T <sub>j</sub> = 150 °C		-		μС
E <sub>rr</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		4		mJ
R <sub>th(j-s)</sub>	per Diode	<u> </u>		1.05		K/W
Diode2	1	1				
$V_F = V_{EC}$	I <sub>F</sub> = 100 A	T <sub>j</sub> = 25 °C		1.40	1.76	V
	chiplevel	T <sub>j</sub> = 150 °C		1.38	1.77	٧
V <sub>F0</sub>	chiplevel	T <sub>i</sub> = 25 °C		1.04	1.24	V
		T <sub>i</sub> = 150 °C		0.85	0.99	٧
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		3.6	5.3	mΩ
		T <sub>j</sub> = 150 °C		5.3	7.8	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 100 A	T <sub>j</sub> = 150 °C				Α
Q <sub>rr</sub>	   V	T <sub>j</sub> = 150 °C				μC
E <sub>rr</sub>	$V_R = 300 \text{ V}$ $V_{GE} = +15/-15 \text{ V}$	T <sub>j</sub> = 150 °C		2.6		mJ
R <sub>th(j-s)</sub>	per Diode	1		1.15		K/W
Module		1				1
L <sub>sCE1</sub>				t.b.d.		nΗ
L <sub>CE</sub>				t.b.d.		nΗ
R <sub>CC'+EE'</sub>		T <sub>s</sub> = 25 °C				mΩ
	_			t.b.d.		mΩ
Ms	to heatsink		2		2.1	Nm
$M_{t}$						Nm
						Nm
W				34		g
Temperat	ture Sensor					
R <sub>100</sub>	$T_c$ =100°C (R <sub>25</sub> =5 kΩ)			493 ± 5%		Ω
B <sub>100/125</sub>	$R_{(T)}=R_{100}exp[B_{100/125}(1/T-1/T_{100})]; T[K];$			3550 ±2%		К







This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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